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A U.S. Department of Energy laboratory managed by The University of Chicago

#### Summary of IEX Device Simulation

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# **Definitions**

Lattice

- APS APS lattice without any insertion devices
- CPU APS + CPU
  - 0.128 x 38 = 4.864 m (mistake)
- IEX1 APS + IEX (first design large roll off)
  - 0.12 x 40 = 4.8 m
- IEX2 APS + IEX (second design smaller roll off)
  - 0.125 x 38 = 4.75 m
- IEX3 APS + IEX (modified of second design slightly large roll off of Bx field)
  - 0.125 x 38 = 4.75 m
- Mode
  - Pure By field H mode.
  - Pure Bx field V mode.
  - Bx + By field C mode (AC by mistake)
- Aperture
  - Transverse aperture (DA) contribution to injection efficiency.
  - Longitudinal aperture (MA) contribution to lifetime.
- Kickmap
  - Int (BL) = kick (x' or y') x 23.3 (T. m)





















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### Attempt of correction









## Summary

- No noticeable changes seen on MA lifetime shouldn't be a problem
- Some decreasing of DA for V and C mode (Bx field)
  - Does this matters?
- IEX effect can not be canceled easily by make on-axis (y=0) kick = 0.
  - Some improvement can be reached by a partial cancellation.
- Question:
  - How good real magnet close to the simulation model?
  - Simulate with errors misalignment and fields, etc.
    - Now only lattice error (Quad., Sextupoles are taken into account)



#### New Results for IEX4 – Nov. 20



















































-200

0

-400



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-0.6

-0.8















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